IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Chih-Wei Hsu, et al.

Docket No.:

24061.49

(TSMC2003-0125)

Serial No.:

10/791,930

Examiner:

**TBD** 

Filed:

March 3, 2004

Entitled:

System and Method for Process

Contamination Prevention for Semiconductor Manufacturing Art Unit:

2121

## INFORMATION DISCLOSURE STATEMENT

Commissioner For Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In compliance with the duty of disclosure under 37 CFR §1.56, and in accordance with the practice under 37 CFR §1.97 and §1.98, the Examiner's attention is directed to the documents listed on the enclosed modified Form PTO-1449. No inference should be made that the cited references are in fact material, are in fact prior art, or that no better art exists. The cited patents are listed in numerical and alphabetical order and are not listed in any order based on their pertinence.

The above-identified application was filed after June 30, 2003. Therefore, pursuant to the waiver of the requirement under 37 CFR 1.98 (a)(2)(i) as stated in a Pre-OG Notice dated July 11, 2003, copies of the U.S. patents listed on the enclosed modified Form PTO-1449 are not being provided.

This Information Disclosure Statement is being filed within three months of the United States filing date or before the mailing date of a first Office Action on the merits. No certification or fee is required (37 CFR §1.97(b)). The Commissioner is hereby authorized to charge any additional fees which may be required or credit any overpayment to Deposit Account 08-1394.

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Respectfully submitted,

24 2. Blin

Timothy F. Bliss

Registration No. 50,925

Date: \_ June 10, 2004

HAYNES AND BOONE, LLP 901 Main Street, Suite 3100 Dallas, Texas 75202-3789 Telephone: 972-739-8638

Facsimile: 214-200-0853

Certificate of Mailing

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to Commissioner For Patents, Washington, D.C. 20231 on the date indicated below:

Name

Date

1	PF				
In place of PTO-1449 Form	PATÉNT ANI	ARTMENT OF COMMERCE AND TRADEMARK OFFICE		Complete if Known	
	l e sobr 튀			Application Number	10/791,930
NFO	RMATION D	ISCLO	SURE	Filing Date	March 3, 2004
STA	EMENT BY	APPLI	CANT	Applicant(s)	Chih-Wei Hsu, et al.
(U	se as many sheets	as necess	ary)	Art Unit	2121
				Examiner Name	TBD
SHEET	1	OF	1	Attorney Docket Number	24061.49 (TSMC2003-0125)

			U. S. PATENT DO	DCUMENTS
Examiner's Initials	Cite No.	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document
	AA	6,349,237	02-19-2002	Koren, et al.
	AB	6,363,294	03-26-2002	Coronel, et al.
	AC	6,408,220	06-18-2002	Nulman
	AD	6,415,193	07-02-2002	Betawar, et al.
	AE	6,473,664	10-29-2002	Lee, et al.
	AF	6,505,090	01-07-2003	Harakawa
	AG	6,546,308	04-08-2003	Takagi, et al.
	AH	US 2003/0069660 A1	04-10-2003	Jun, et al.
			-	
	•			
	-			

<sup>9</sup> FOREIGN PATENT DOCUMENTS					
Examiner's Initials	Cite No.	Foreign Patent Document (Country Code – Number – Kind)	Publication Date	Patentee or Applicant of Cited Document	Translation YN
	-				

	,	OTHER PRIOR ART
Examiner's Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item, date, page(s), volume- issue number(s), publisher, city/country where published

Examiner	Date
Signature	Considered

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.

R-76969\_1.DOC Customer No. 27683